**Product data sheet** 

## 1. Product profile

## 1.1 General description

NPN silicon microwave transistor for high speed, low noise applications in a plastic, 4-pin dual-emitter SOT343F package.

### 1.2 Features and benefits

- Low noise high linearity microwave transistor
- High output third-order intercept point 34 dBm at 1.8 GHz
- 40 GHz f<sub>T</sub> silicon technology

### 1.3 Applications

- Ka band oscillators DRO's
- C-band high output buffer amplifier
- ZigBee
- LTE, cellular, UMTS

### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{CBO}$	collector-base voltage	open emitter	-	-	16	V
$V_{CEO}$	collector-emitter voltage	open base	-	-	5.5	V
$V_{EBO}$	emitter-base voltage	open collector	-	-	2.5	V
I <sub>C</sub>	collector current		-	70	100	mA
P <sub>tot</sub>	total power dissipation	$T_{sp} \le 85  ^{\circ}C$	-	-	490	mW
h <sub>FE</sub>	DC current gain	$I_C$ = 20 mA; $V_{CE}$ = 2 V; $T_j$ = 25 °C	90	135	180	
C <sub>CBS</sub>	collector-base capacitance	V <sub>CB</sub> = 2 V; f = 1 MHz	-	404	-	fF
f⊤	transition frequency	$I_C = 60$ mA; $V_{CE} = 1$ V; $f = 2$ GHz; $T_{amb} = 25$ °C	-	18	-	GHz
$G_{p(max)}$	maximum power gain	$I_C = 60 \text{ mA}; V_{CE} = 1 \text{ V}; f = 1.8 \text{ GHz};$ $T_{amb} = 25 \text{ °C}$	-	20.5	-	dB
NF	noise figure	$I_C$ = 15 mA; $V_{CE}$ = 2 V; f = 1.8 GHz; $\Gamma_S$ = $\Gamma_{opt}$	-	0.65	-	dB
P <sub>L(1dB)</sub>	output power at 1 dB gain compression	$I_C$ = 70 mA; $V_{CE}$ = 4 V; $Z_S$ = $Z_L$ = 50 $\Omega$ ; f = 1.8 GHz; $T_{amb}$ = 25 °C	-	22	-	dBm

<sup>[1]</sup>  $T_{sp}$  is the temperature at the solder point of the emitter lead.

 $<sup>\</sup>label{eq:Gpmax} \mbox{[2]} \quad \mbox{$G_{p(max)}$ is the maximum power gain, if $K > 1$. If $K < 1$ then $G_{p(max)}$ = Maximum Stable Gain (MSG).}$ 



# 2. Pinning information

Table 2. Discrete pinning

Pin	Description	Simplified outline	Graphic symbol
1	emitter		
2	base	3 4	4
3	emitter		2 —
4	collector		.)
			1, 3
		2 1	mbb159

# 3. Ordering information

Table 3. Ordering information

Type number	r Package			
	Name	Description	Version	
BFU690F	-	plastic surface-mounted flat pack package; reverse pinning; 4 leads	SOT343F	

# 4. Marking

Table 4. Marking

Type number	Marking	Description
BFU690F	D4*	* = p : made in Hong Kong
		* = t : made in Malaysia
		* = w : made in China

# 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CBO}$	collector-base voltage	open emitter	-	16	V
$V_{CEO}$	collector-emitter voltage	open base	-	5.5	V
$V_{EBO}$	emitter-base voltage	open collector	-	2.5	V
I <sub>C</sub>	collector current		-	100	mA
P <sub>tot</sub>	total power dissipation	$T_{sp} \le 85  ^{\circ}C$ [1]	-	490	mW
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature		-	150	°C

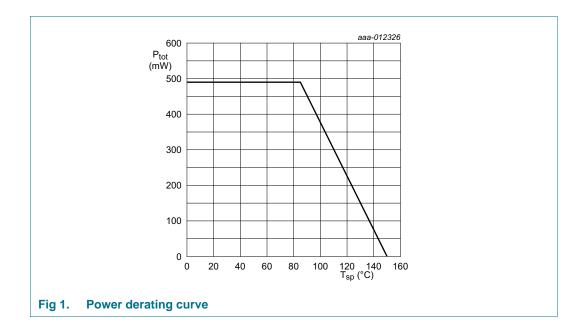
<sup>[1]</sup>  $T_{sp}$  is the temperature at the solder point of the emitter lead.

# 6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	<u>[1]</u>	132	K/W

[1] Determined by simulation.



### NPN wideband silicon RF transistor

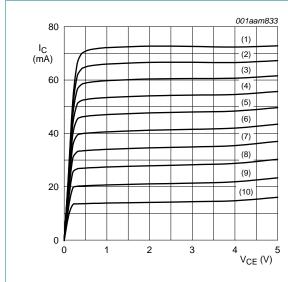
# 7. Characteristics

Table 7. Characteristics

 $T_j = 25$  °C unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>(BR)CBO</sub>	collector-base breakdown voltage	$I_C = 2.5 \mu A; I_E = 0 \text{ mA}$	16	-	-	V
V <sub>(BR)CEO</sub>	collector-emitter breakdown voltage	I <sub>C</sub> = 1 mA; I <sub>B</sub> = 0 mA	5.5	-	-	V
I <sub>C</sub>	collector current		-	70	100	mΑ
I <sub>CBO</sub>	collector-base cut-off current	I <sub>E</sub> = 0 mA; V <sub>CB</sub> = 8 V	-	-	100	nΑ
h <sub>FE</sub>	DC current gain	I <sub>C</sub> = 20 mA; V <sub>CE</sub> = 2 V	90	135	180	
C <sub>CES</sub>	collector-emitter capacitance	V <sub>CB</sub> = 2 V; f = 1 MHz	-	527	-	fF
C <sub>EBS</sub>	emitter-base capacitance	V <sub>EB</sub> = 0.5 V; f = 1 MHz	-	1699	-	fF
C <sub>CBS</sub>	collector-base capacitance	V <sub>CB</sub> = 2 V; f = 1 MHz	-	404	-	fF
f <sub>T</sub>	transition frequency	$I_C$ = 60 mA; $V_{CE}$ = 1 V; f = 2 GHz; $T_{amb}$ = 25 °C	-	18	-	GHz
G <sub>p(max)</sub>	maximum power gain	$I_C = 60 \text{ mA}; V_{CE} = 1 \text{ V}; T_{amb} = 25 \text{ °C}$ [1]				
		f = 1.5 GHz	-	22	-	dB
		f = 1.8 GHz	-	20.5	-	dB
		f = 2.4 GHz	-	17	-	dB
S <sub>21</sub>   <sup>2</sup>	insertion power gain	$I_C = 60 \text{ mA}; V_{CE} = 1 \text{ V}; T_{amb} = 25 \text{ °C}$				
		f = 1.5 GHz	-	15	-	dB
		f = 1.8 GHz	-	13.5	-	dB
		f = 2.4 GHz	-	11	-	dB
NF	noise figure	$I_C$ = 15 mA; $V_{CE}$ = 2 V; $\Gamma_S$ = $\Gamma_{opt}$ ; $\Gamma_{amb}$ = 25 °C				
		f = 1.5 GHz	-	0.60	-	dB
		f = 1.8 GHz	-	0.65	-	dB
		f = 2.4 GHz	-	0.70	-	dB
G <sub>ass</sub>	associated gain	$I_C$ = 15 mA; $V_{CE}$ = 2 V; $\Gamma_S$ = $\Gamma_{opt}$ ; $T_{amb}$ = 25 °C				
		f = 1.5 GHz	-	18.5	-	dB
		f = 1.8 GHz	-	17.5	-	dB
		f = 2.4 GHz	-	15.5	-	dB
P <sub>L(1dB)</sub>	output power at 1 dB gain compression	$I_C$ = 70 mA; $V_{CE}$ = 4 V; $Z_S$ = $Z_L$ = 50 $\Omega$ ; $T_{amb}$ = 25 °C				
		f = 1.5 GHz	-	22	-	dBm
		f = 1.8 GHz	-	22	-	dBm
		f = 2.4 GHz	-	20	-	dBm
IP3	third-order intercept point	$I_C$ = 70 mA; $V_{CE}$ = 4 V; $Z_S$ = $Z_L$ = 50 $\Omega$ ; $T_{amb}$ = 25 °C				
		f = 1.5 GHz	-	34	-	dBm
		f = 1.8 GHz	-	34	-	dBm
		f = 2.4 GHz		33		dBm

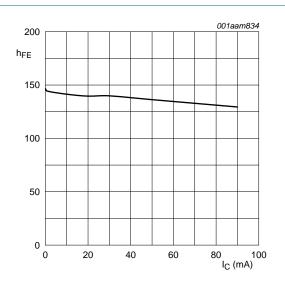
<sup>[1]</sup>  $G_{p(max)}$  is the maximum power gain, if K > 1. If K < 1 then  $G_{p(max)} = MSG$ .



 $T_{amb} = 25 \, ^{\circ}C.$ 

- (1)  $I_B = 550 \mu A$
- (2)  $I_B = 500 \mu A$
- (3)  $I_B = 450 \mu A$
- (4)  $I_B = 400 \mu A$
- (5)  $I_B = 350 \mu A$
- (6)  $I_B = 300 \mu A$
- (7)  $I_B = 250 \mu A$
- (8)  $I_B = 200 \mu A$ (9)  $I_B = 150 \mu A$
- (10)  $I_B = 100 \mu A$

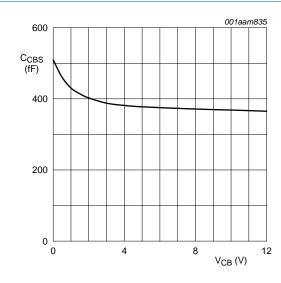
Fig 2. Collector current as a function of collector-emitter voltage; typical values



 $V_{CE} = 2 \text{ V}; T_{amb} = 25 \,^{\circ}\text{C}.$ 

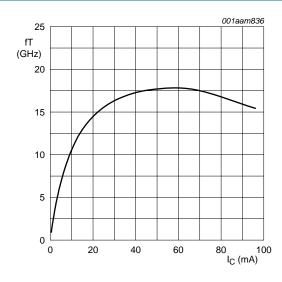
Fig 3. DC current gain as a function of collector current; typical values

### NPN wideband silicon RF transistor



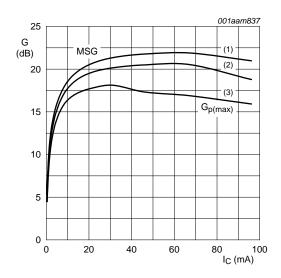
f = 1 MHz,  $T_{amb} = 25$  °C.

Fig 4. Collector-base capacitance as a function of collector-base voltage; typical values



 $V_{CE} = 1 \text{ V; } f = 2 \text{ GHz; } T_{amb} = 25 \text{ }^{\circ}\text{C}.$ 

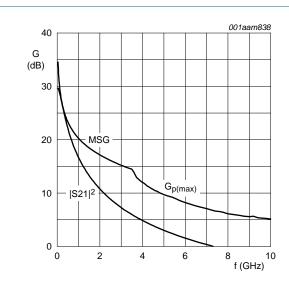
Fig 5. Transition frequency as a function of collector current; typical values



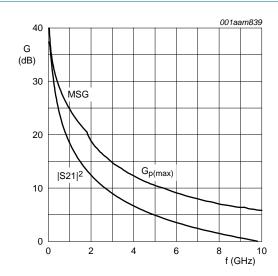
 $V_{CE} = 1 \text{ V; } T_{amb} = 25 \text{ }^{\circ}\text{C.}$ 

- (1) f = 1.5 GHz
- (2) f = 1.8 GHz
- (3) f = 2.4 GHz

Fig 6. Gain as a function of collector current; typical value



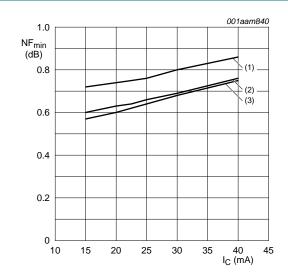
 $V_{CE}$  = 1 V;  $I_{C}$  = 10 mA;  $T_{amb}$  = 25 °C.



 $V_{CE}$  = 1 V;  $I_{C}$  = 60 mA;  $T_{amb}$  = 25 °C.

Fig 7. Gain as a function of frequency; typical values

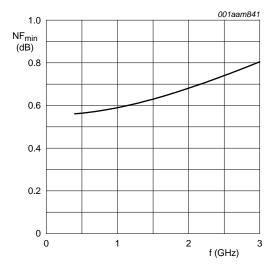




 $V_{CE}$  = 2 V;  $T_{amb}$  = 25 °C.

- (1) f = 2.4 GHz
- (2) f = 1.8 GHz
- (3) f = 1.5 GHz

Fig 9. Minimum noise figure as a function of collector current; typical values



 $V_{CE}$  = 2 V;  $I_{C}$  = 15 mA;  $T_{amb}$  = 25 °C.

Fig 10. Minimum noise figure as a function of frequency; typical values

# Package outline

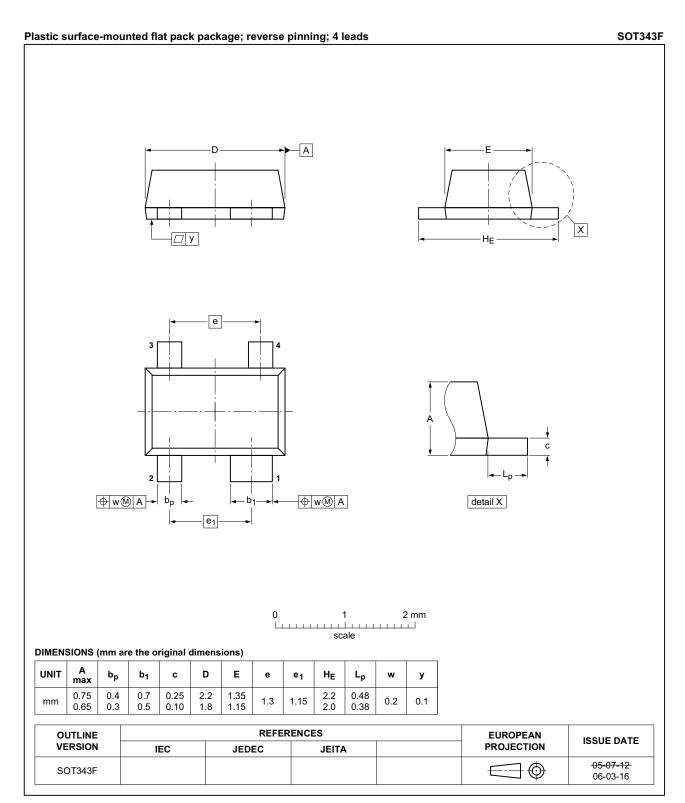


Fig 11. Package outline SOT343F

### **NPN** wideband silicon RF transistor

# 9. Handling information

### CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

# 10. Abbreviations

Table 8. Abbreviations

Acronym	Description
DRO	Dielectric Resonator Oscillator
Ka	Kurtz above
LTE	Long Term Evolution
NPN	Negative-Positive-Negative
UMTS	Universal Mobile Telecommunications System

# 11. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes		
BFU690F v.2	20140314	Product data sheet	-	BFU690F v.1		
Modifications:	Table 1 on pa	Table 1 on page 1: The value and conditions for Ptot have been updated.				
	<ul> <li><u>Table 5 on page 2</u>: The value and conditions for P<sub>tot</sub> have been updated.</li> </ul>					
	<ul> <li><u>Table 6 on page 3</u>: The value and conditions for R<sub>th(j-sp)</sub> have been updated.</li> </ul>					
	• Figure 1 on page 3: The graph has been updated.					
	• Section 9 on page 9: The ESD caution has been moved here from Section 1.1 on page 1.					
BFU690F v.1	20101216	Product data sheet	-	-		

# 12. Legal information

#### 12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions"
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#### NPN wideband silicon RF transistor

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### NPN wideband silicon RF transistor

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